











SN74LVC1G66

SCES323Q - JUNE 2001 - REVISED MARCH 2017

# SN74LVC1G66 Single Bilateral Analog Switch

#### **Features**

- Available in the Texas Instruments NanoFree™ Package
- 1.65-V to 5.5-V V<sub>CC</sub> Operation
- Inputs Accept Voltages to 5.5 V
- Max  $t_{pd}$  of 0.8 ns at 3.3 V
- High On-Off Output Voltage Ratio
- High Degree of Linearity
- High Speed, Typically 0.5 ns ( $V_{CC} = 3 \text{ V}$ ,  $C_{L} = 50 \text{ pF}$
- Low ON-State Resistance, Typically ≉5.5 Ω (V<sub>CC</sub>
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

## 2 Applications

- Wireless Devices
- Audio and Video Signal Routing
- Portable Computing
- Wearable Devices
- Signal Gating, Chopping, Modulation or Demodulation (Modem)
- Signal Multiplexing for Analog-to-Digital and Digital-to-Analog Conversion Systems

## 3 Description

This single analog switch is designed for 1.65-V to 5.5-V  $V_{CC}$  operation.

The SN74LVC1G66 device can handle analog and digital signals. The device permits bidirectional transmission of signals with amplitudes of up to 5.5 V (peak).

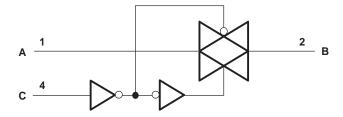
NanoFree package technology is breakthrough in IC packaging concepts, using the die as the package.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
SN74LVC1G66DBV	SOT-23 (5)	2.90 mm × 1.60 mm		
SN74LVC1G66DCK	SC70 (5)	2.00 mm × 1.25 mm		
SN74LVC1G66DRL	SOT (5)	1.60 mm × 1.20 mm		
SN74LVC1G66DRY	SON (6)	1.45 mm × 1.00 mm		
SN74LVC1G66YZP	DSBGA (5)	1.39 mm × 0.89 mm		
SN74LVC1G66DSF	SON (6)	1.00 mm x 1.00 mm		

(1) For all available packages, see the orderable addendum at the end of the datasheet.

## Logic Diagram (Positive Logic)



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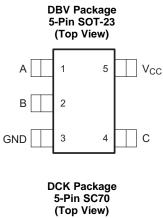
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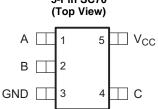
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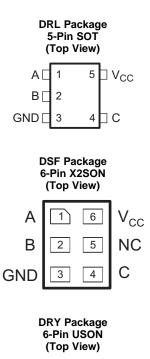
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# 5 Pin Configuration and Functions





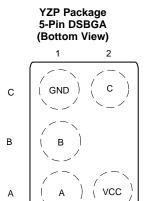


# A 1 6 V<sub>CC</sub> B 2 5 NC GND 3 4 C

#### **Pin Functions**

	PIN						
NAME	SOT NO.	USON, X2SON NO.	I/O	DESCRIPTION			
Α	1	1	I/O	I/O Bidirectional signal to be switched			
В	2	2	I/O	Bidirectional signal to be switched			
С	4	4	Ι	Controls the switch (L = OFF, H = ON)			
GND	3	3	1	Ground pin			
NC	_	5	1	Do not connect			
V <sub>CC</sub>	5	6	_	Power pin			





## **Pin Functions**

	PIN			
NAME	DSBGA NO.	I/O	DESCRIPTION	
Α	A1	I/O	Bidirectional signal to be switched	
В	B1	I/O	Bidirectional signal to be switched	
С	C2	I	Controls the switch (L = OFF, H = ON)	
GND	C1	_	Ground pin	
V <sub>CC</sub>	A2	_	Power pin	



## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage <sup>(2)</sup>		-0.5	6.5	V
VI	Input voltage <sup>(2)(3)</sup>			6.5	V
V <sub>I/O</sub>	Switch I/O voltage <sup>(2)(3)(4)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Control input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>IOK</sub>	I/O port diode current	$V_{I/O}$ < 0 or $V_{I/O}$ > $V_{CC}$		±50	mA
I <sub>T</sub>	ON-state switch current	$V_{I/O}$ < 0 to $V_{CC}$		±50	mA
	Continuous current through V <sub>CC</sub> or GND		±100	mA	
T <sub>stg</sub>	Storage Temperature	-65	150	°C	
Tj	Junction Temperature			150	°C

<sup>(1)</sup> Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings

			VALUE	UNIT
	Human-body m	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	+2000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	+1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		1.65	5.5	V	
V <sub>I/O</sub>	I/O port voltage.		0	V <sub>CC</sub>	V	
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	$V_{CC} \times 0.65$			
\/	Lligh level input voltage, control input	V <sub>CC</sub> = 2.3 V to 2.7 V	V <sub>CC</sub> × 0.7		V	
$V_{IH}$	High-level input voltage, control input	V <sub>CC</sub> = 3 V to 3.6 V	V <sub>CC</sub> × 0.7		V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	$V_{CC} \times 0.7$			
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		$V_{CC} \times 0.35$		
.,	Low-level input voltage, control input	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$	V	
$V_{IL}$		V <sub>CC</sub> = 3 V to 3.6 V		V <sub>CC</sub> × 0.3	V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		$V_{CC} \times 0.3$		
VI	Control input voltage		0	5.5	V	
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		20		
41/4	Operational formers through the series and delite the series	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		20	A /	
Δt/Δv	Control input transition rise and fall time	V <sub>CC</sub> = 3 V to 3.6 V		10	ns/V	
		V <sub>CC</sub> = 4.5 V to 5.5 V		10		
T <sub>A</sub>	Operating free-air temperature	_	-40	85	°C	

All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, SCBA004.

<sup>(2)</sup> All voltages are with respect to ground, unless otherwise specified.

<sup>(3)</sup> The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>(4)</sup> This value is limited to 5.5 V maximum.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 6.4 Thermal Information

		SN74LVC1G66						
	THERMAL METRIC		DCK (SC70)	DRL (SOT)	DRY (USON)	DSF (X2SON)	YZP (DSBGA)	UNIT
		5 PINS	5 PINS	5 PINS	6 PINS	6 PINS	5 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	206	252	142		_	132	°C/W

## 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITI	ONS	V <sub>CC</sub>	MIN TYP(1)	MAX	UNIT
		$V_{I} = V_{CC}$ or GND,	I <sub>S</sub> = 4 mA	1.65 V	12	30	
_	ON state switch resistance	$V_{I} = V_{CC}$ of GND, $V_{C} = V_{IH}$	I <sub>S</sub> = 8 mA	2.3 V	9	20	Ω
r <sub>on</sub>	ON-state switch resistance	(see Figure 2 and	I <sub>S</sub> = 24 mA	3 V	7.5	15	12
		Figure 1)	I <sub>S</sub> = 32 mA	4.5 V	5.5	10	
		V. – V or GND	$I_S = 4 \text{ mA}$	1.65 V	74.5	120	
_	Dook on vaciations	$V_I = V_{CC}$ or GND, $V_C = V_{IH}$	$I_S = 8 \text{ mA}$	2.3 V	20	30	Ω
r <sub>on(p)</sub>	Peak on resistance	(see Figure 2 and	I <sub>S</sub> = 24 mA	3 V	11.5	20	12
		Figure 1)	I <sub>S</sub> = 32 mA	4.5 V	7.5	15	
		$V_I = V_{CC}$ and $V_O = GND$ or				±1	
I <sub>S(off)</sub>	OFF-state switch leakage current	$V_I = GND$ and $V_O = V_{CC}$ , $V_C = V_{IL}$ (see Figure 3)	T <sub>A</sub> = 25°C	5.5 V		±0.1	μА
		$V_I = V_{CC}$ or GND, $V_C = V_{IH}$ ,				±1	
I <sub>S(on)</sub>	ON-state switch leakage current	V <sub>O</sub> = Open (see Figure 4)	T <sub>A</sub> = 25°C	5.5 V		±0.1	μА
I.	Control input current	$V_C = V_{CC}$ or GND		5.5 V		±1	^
l <sub>l</sub>	Control input current	AC = ACC OL GIAD	T <sub>A</sub> = 25°C	3.5 V		±0.1	μΑ
1	Supply current	$V_C = V_{CC}$ or GND		5.5 V		10	
I <sub>CC</sub>	Supply current	AC = ACC OL GIAD	T <sub>A</sub> = 25°C	3.5 V		1	μА
$\Delta I_{CC}$	Supply current change	$V_C = V_{CC} - 0.6 V$		5.5 V		500	μΑ
C <sub>ic</sub>	Control input capacitance			5 V	2		pF
C <sub>io(off)</sub>	Switch input and output capacitance			5 V	6		pF
C <sub>io(on)</sub>	Switch input and output capacitance			5 V	13		рF

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 

## 6.6 Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 5)

	PARAMETER	FROM	TO (OUTBUT)	V <sub>CC</sub> = 1.8 V ± 0.15 V			V <sub>CC</sub> = 3.3 V ± 0.3 V		5 V 5 V	UNIT		
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
	t <sub>pd</sub> <sup>(1)</sup>	A or B	B or A		2		1.2		0.8		0.6	ns
	t <sub>en</sub> <sup>(2)</sup>	С	A or B	2.5	12	1.9	6.5	1.8	5	1.5	4.2	ns
	t <sub>dis</sub> (3)	С	A or B	2.2	10	1.4	6.9	2	6.5	1.4	5	ns

<sup>(1)</sup> t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>. The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

 <sup>(2)</sup> t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
 (3) t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.



# 6.7 Analog Switch Characteristics

 $T_A = 25^{\circ}C$ 

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V <sub>cc</sub>	TYP	UNIT
				1.65 V	35	
			$C_L = 50 \text{ pF}, R_L = 600 \Omega,$	2.3 V	120	1
			f <sub>in</sub> = sine wave (see Figure 6)	3 V	175	
Frequency response <sup>(1)</sup>	A or B	D A	,	4.5 V	195	
(switch ON)	A OF B	B or A		1.65 V	>300	MHz
			$C_L = 5 \text{ pF}, R_L = 50 \Omega,$	2.3 V	>300	Ì
	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Ì				
			4.5 V >300	ı		
				1.65 V	35	i
Crosstalk	0	C A or B $f_{in} = 1$ MHz (square wave) (see Figure 7) $3 \text{ V}$ $70$	50	\/		
(control input to signal output)	C			3 V	70	mV
			100			
				1.65 V	√ –58	i
			$C_L = 50 \text{ pF}, R_L = 600 \Omega,$ $f_{in} = 1 \text{ MHz (sine wave)}$ (see Figure 8)	2.3 V	-58	dB
				3 V	-58	
Feedthrough attenuation (2)	A == D	D == 4	,	4.5 V	-58	
(switch OFF)	A or B	B or A		1.65 V	-42	
			$C_L = 5 \text{ pF}, R_L = 50 \Omega,$	2.3 V	-42	
			f <sub>in</sub> = 1 MHz (sine wave) (see Figure 8)	3 V	-42	
			31 1 1	4.5 V	-42	ı
				1.65 V	0.1%	i
			$C_L = 50 \text{ pF}, R_L = 10 \text{ k}\Omega,$	2.3 V	0.025%	Ī
			f <sub>in</sub> = 1 kHz (sine wave) (see Figure 9)	3 V	0.015%	
Cin a viva in diatantia in	A == D	D == 4	,	4.5 V	0.01%	İ
Sine-wave distortion	A or B	B or A		1.65 V	0.15%	İ
			$C_L = 50 \text{ pF}, R_L = 10 \text{ k}\Omega,$	2.3 V	0.025%	İ
			f <sub>in</sub> = 10 kHz (sine wave) (see Figure 9)	3 V	0.015%	1
				4.5 V	0.01%	Ī

<sup>(1)</sup> Adjust  $f_{in}$  voltage to obtain 0 dBm at output. Increase  $f_{in}$  frequency until dB meter reads -3 dB. (2) Adjust  $f_{in}$  voltage to obtain 0 dBm at input.

# 6.8 Operating Characteristics

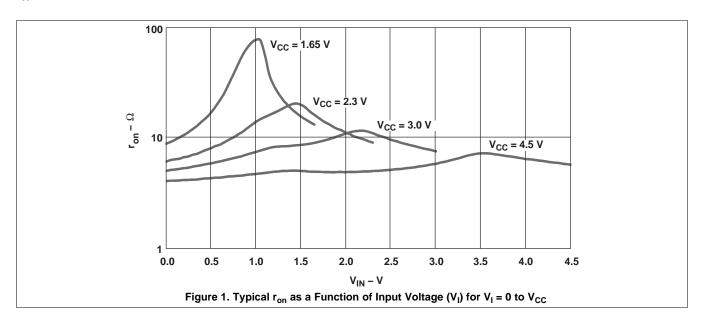
 $T_A = 25^{\circ}C$ 

PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	V <sub>CC</sub> = 5 V TYP	UNIT
$C_{pd}$	Power dissipation capacitance	f = 10 MHz	8	9	9	11	pF



# 6.9 Typical Characteristics

 $T_A = 25^{\circ}C$ 





## 7 Parameter Measurement Information

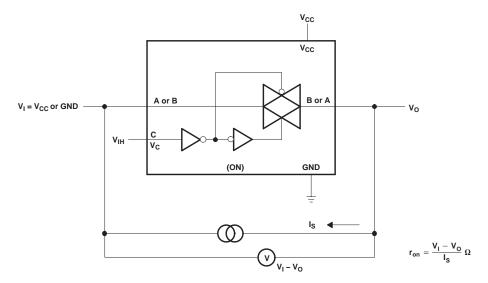


Figure 2. ON-State Resistance Test Circuit

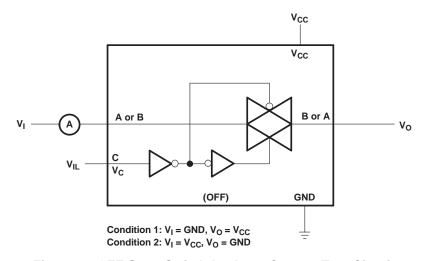


Figure 3. OFF-State Switch Leakage-Current Test Circuit

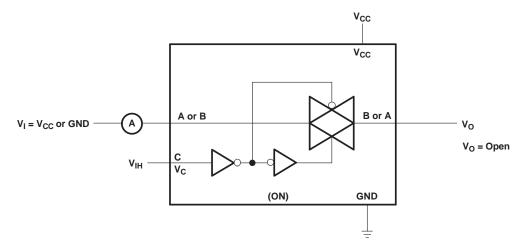
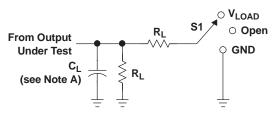


Figure 4. ON-State Switch Leakage-Current Test Circuit

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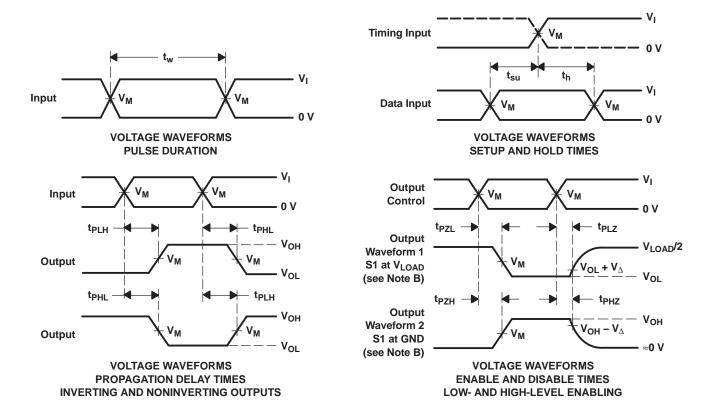
#### **Parameter Measurement Information (continued)**



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

**LOAD CIRCUIT** 

.,	INI	PUTS	.,	V	0		v
VCC	V <sub>CC</sub> V <sub>I</sub> t <sub>r</sub> /t <sub>f</sub>		V <sub>M</sub>	V <sub>LOAD</sub>	CL	R <sub>L</sub>	$oldsymbol{V}_\Delta$
1.8 V $\pm$ 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	$v_{cc}$	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	500 Ω	0.15 V
3.3 V $\pm$ 0.3 V	$V_{CC}$	≤2.5 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	50 pF	500 Ω	0.3 V
5 V $\pm$ 0.5 V	$v_{cc}$	≤2.5 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	50 pF	500 Ω	0.3 V



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 5. Load Circuit and Voltage Waveforms

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# **Parameter Measurement Information (continued)**

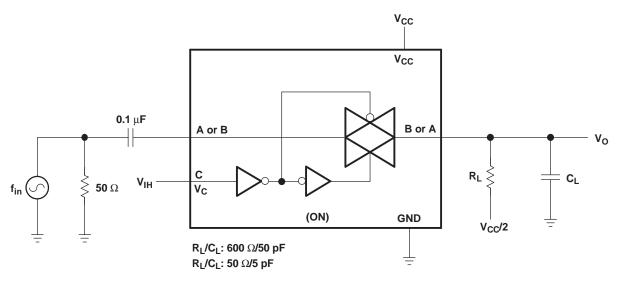


Figure 6. Frequency Response (Switch ON)

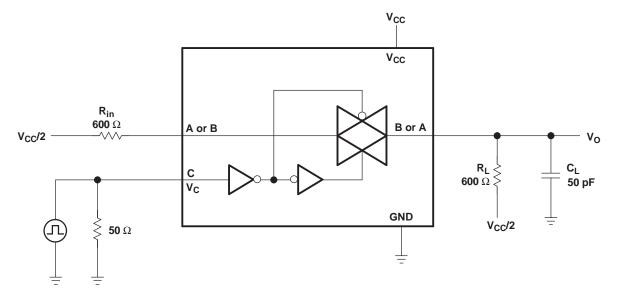


Figure 7. Crosstalk (Control Input – Switch Output)



# **Parameter Measurement Information (continued)**

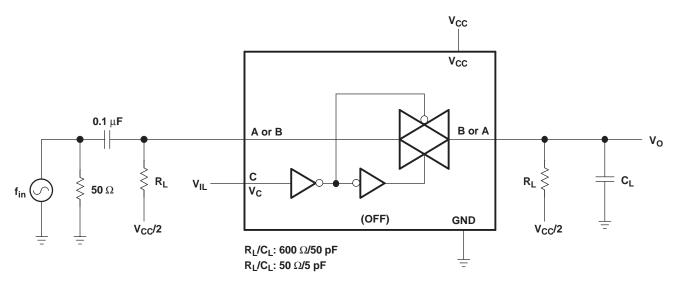


Figure 8. Feedthrough (Switch OFF)

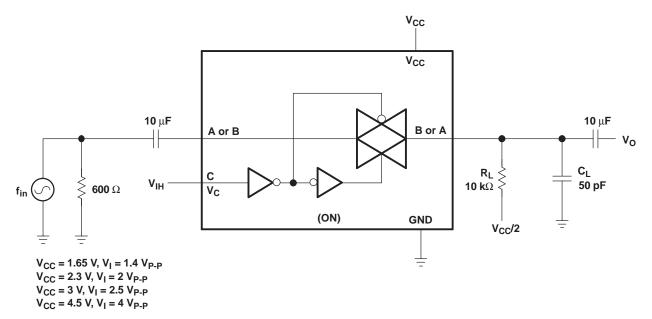


Figure 9. Sine-Wave Distortion

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## 8 Detailed Description

#### 8.1 Overview

This single analog switch is designed for 1.65-V to 5.5-V  $V_{CC}$  operation.

The SN74LVC1G66 device can handle analog and digital signals. The device permits bidirectional transmission of signals with amplitudes of up to 5.5 V (peak). Like all analog switches, the SN74LVC1G66 is bidirectional.

NanoFree package technology is a major breakthrough in IC packaging concepts, using the die as the package.

#### 8.2 Functional Block Diagram

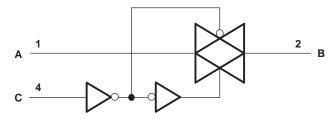


Figure 10. Logic Diagram (Positive Logic)

## 8.3 Feature Description

The TI NanoFree package is one of TI's smallest packages and allows customers to save board space while the solder bumps allow for easy testing. The SN74LVC1G66 has a wide  $V_{CC}$  range, allowing rail-to-rail operation of signals anywhere from a 1.8-V system to a 5-V system. In addition, the control input (C Pin) is 5.5-V tolerant, allowing higher-voltage logic to interface to the switch control system.

#### 8.4 Device Functional Modes

**Table 1. Function Table** 

CONTROL INPUT (C)	SWITCH
L	OFF
Н	ON

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## 9 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Application Information

The SN74LVC1G66 can be used in any situation where an SPST switch would be used and a solid-state, voltage-controlled version is preferred.

## 9.2 Typical Application

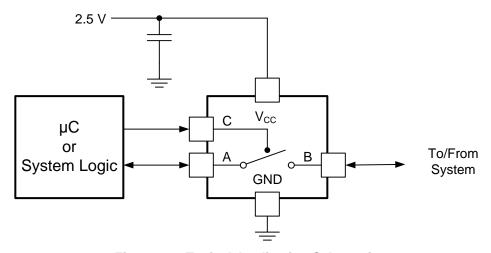


Figure 11. Typical Application Schematic

#### 9.2.1 Design Requirements

The SN74LVC1G66 allows on and off control of analog and digital signals with a digital control signal. All input signals should remain between 0 V and V<sub>CC</sub> for optimal operation.

#### 9.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions:
  - For rise time and fall time specifications, see Δt/Δv in Recommended Operating Conditions.
  - For specified high and low levels, see V<sub>IH</sub> and V<sub>IL</sub> in Recommended Operating Conditions.
  - Inputs and outputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V<sub>CC</sub>.
- 2. Recommended Output Conditions:
  - Load currents should not exceed ±50 mA.
- 3. Frequency Selection Criterion:
  - Maximum frequency tested is 150 MHz.
  - Added trace resistance/capacitance can reduce maximum frequency capability; use layout practices as directed in Layout.

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## **Typical Application (continued)**

#### 9.2.3 Application Curve

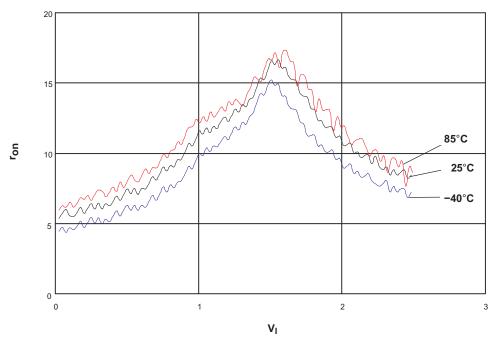


Figure 12.  $r_{on}$  vs  $V_l$ ,  $V_{CC} = 2.5 \text{ V (SN74LVC1G66)}$ 

## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*.

Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1- $\mu F$  bypass capacitor is recommended. If there are multiple pins labeled  $V_{CC}$ , then a 0.01- $\mu F$  or 0.022- $\mu F$  capacitor is recommended for each  $V_{CC}$  because the  $V_{CC}$  pins will be tied together internally. For devices with dual supply pins operating at different voltages, for example  $V_{CC}$  and  $V_{DD}$ , a 0.1- $\mu F$  bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1- $\mu F$  and 1- $\mu F$  capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

## 11 Layout

## 11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self–inductance of the trace — resulting in the reflection. It is a given that not all PCB traces can be straight, and so they will have to turn corners. Figure 13 shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.



# 11.2 Layout Example

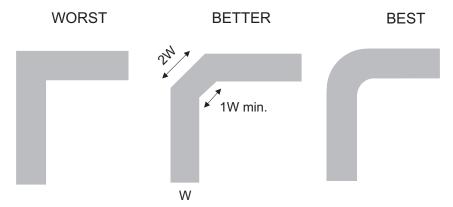


Figure 13. Trace Example



## 12 Device and Documentation Support

## 12.1 Documentation Support

#### 12.1.1 Related Documentation

• Implications of Slow or Floating CMOS Inputs, SCBA004

#### 12.2 Trademarks

NanoFree is a trademark of Texas Instruments. All other trademarks are the property of their respective owners.

#### 12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 12.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 1-May-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
part framber	(1)	(2)			(3)	(4)	(5)		(6)
SN74LVC1G66DBVR	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU   SN   NIPDAU		-40 to 85	(C665, C66J, C66R, C66T)
SN74LVC1G66DBVT	Obsolete	Production	SOT-23 (DBV)   5	-	-	Call TI	Call TI	-40 to 85	(C665, C66J, C66R)
SN74LVC1G66DCKR	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU   SN   NIPDAU	Level-1-260C-UNLIM	-40 to 85	(C65, C6F, C6J, C6 K, C6O, C6R, C 6T)
SN74LVC1G66DCKT	Obsolete	Production	SC70 (DCK)   5	-	-	Call TI	Call TI	-40 to 85	(C65, C6J, C6R, C6 T)
SN74LVC1G66DRLR	Active	Production	SOT-5X3 (DRL)   5	4000   LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	(C67, C6R)
SN74LVC1G66DRYR	Active	Production	SON (DRY)   6	5000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	C6
SN74LVC1G66DSF2	Obsolete	Production	SON (DSF)   6	-	-	Call TI	Call TI	-40 to 85	C6
SN74LVC1G66DSFR	Active	Production	SON (DSF)   6	5000   LARGE T&R	Yes	NIPDAU   NIPDAU	Level-1-260C-UNLIM	-40 to 85	C6
SN74LVC1G66YZPR	Active	Production	DSBGA (YZP)   5	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	C6N

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE OPTION ADDENDUM**

www.ti.com 1-May-2025

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN74LVC1G66:

Automotive: SN74LVC1G66-Q1

NOTE: Qualified Version Definitions:

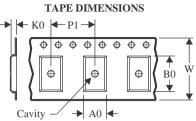
Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects



www.ti.com 14-Dec-2024

## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC1G66DBVR	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
SN74LVC1G66DCKR	SC70	DCK	5	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
SN74LVC1G66DRLR	SOT-5X3	DRL	5	4000	180.0	8.4	1.98	1.78	0.69	4.0	8.0	Q3
SN74LVC1G66DRYR	SON	DRY	6	5000	180.0	9.5	1.15	1.6	0.75	4.0	8.0	Q1
SN74LVC1G66DSFR	SON	DSF	6	5000	180.0	8.4	1.16	1.16	0.5	4.0	8.0	Q2
SN74LVC1G66YZPR	DSBGA	YZP	5	3000	178.0	9.2	1.02	1.52	0.63	4.0	8.0	Q1



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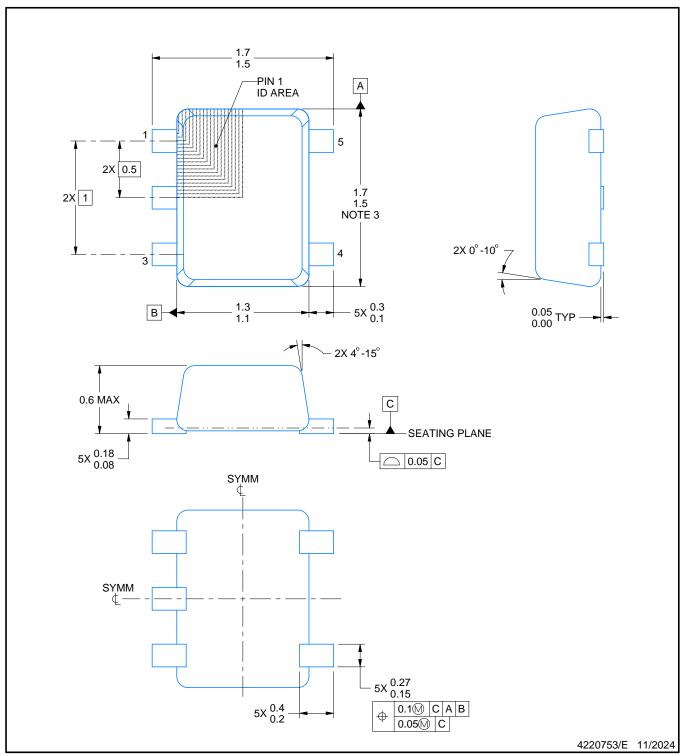


## \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC1G66DBVR	SOT-23	DBV	5	3000	180.0	180.0	18.0
SN74LVC1G66DCKR	SC70	DCK	5	3000	180.0	180.0	18.0
SN74LVC1G66DRLR	SOT-5X3	DRL	5	4000	202.0	201.0	28.0
SN74LVC1G66DRYR	SON	DRY	6	5000	184.0	184.0	19.0
SN74LVC1G66DSFR	SON	DSF	6	5000	210.0	185.0	35.0
SN74LVC1G66YZPR	DSBGA	YZP	5	3000	220.0	220.0	35.0



PLASTIC SMALL OUTLINE

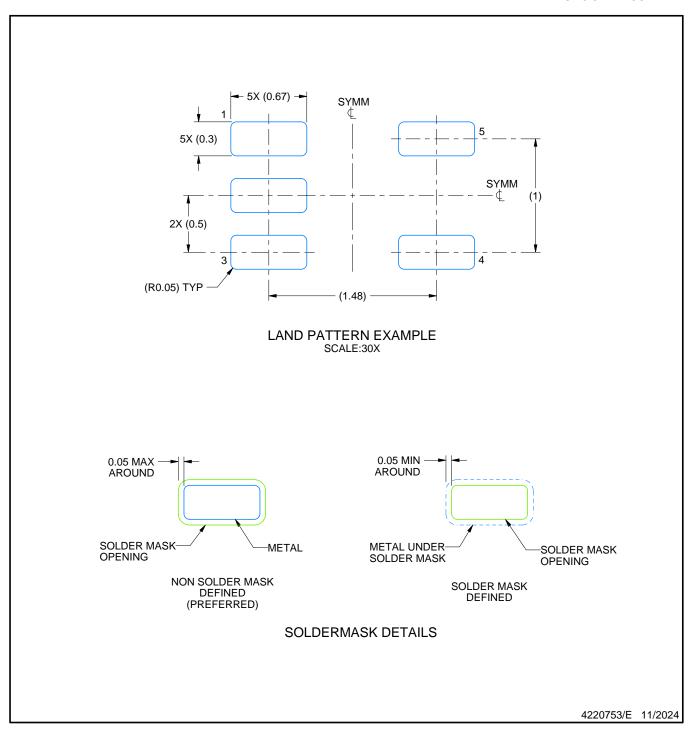


#### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
   This drawing is subject to change without notice.
   This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-293 Variation UAAD-1



PLASTIC SMALL OUTLINE

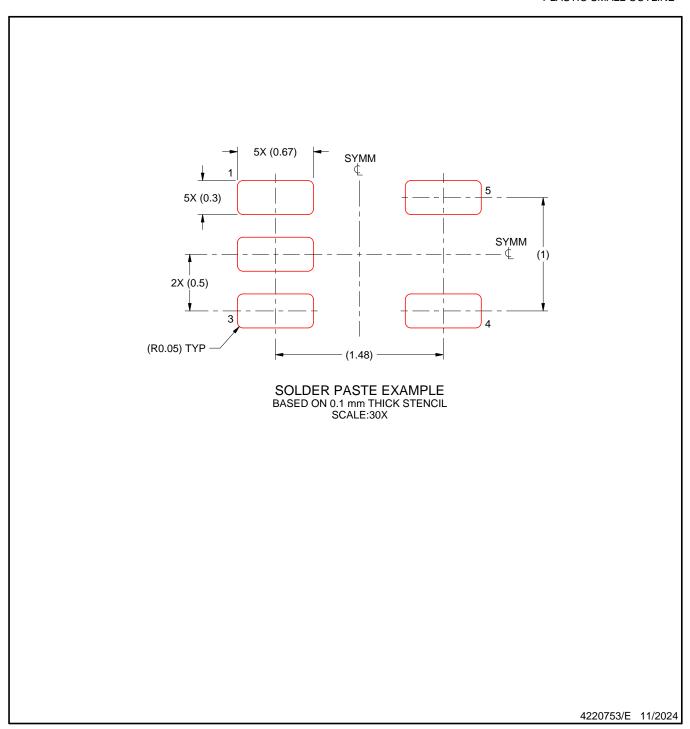


NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC SMALL OUTLINE



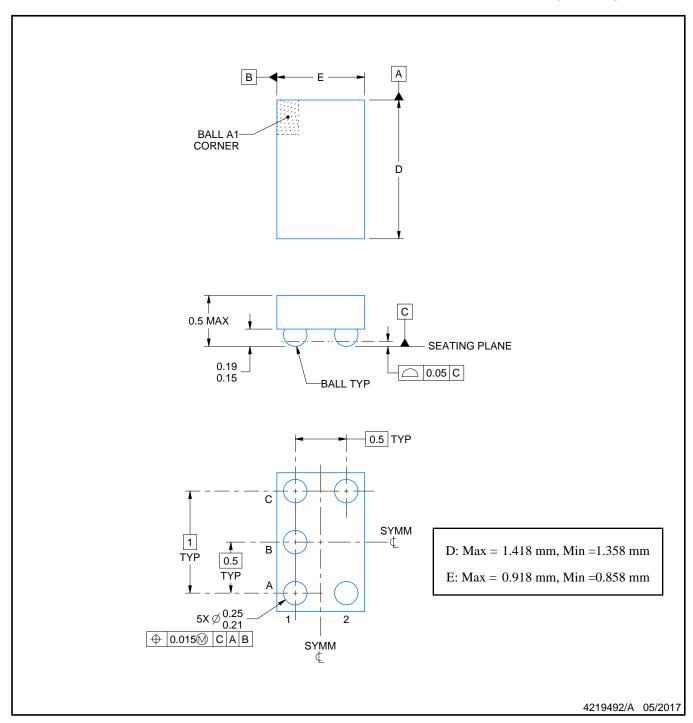
NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.





DIE SIZE BALL GRID ARRAY

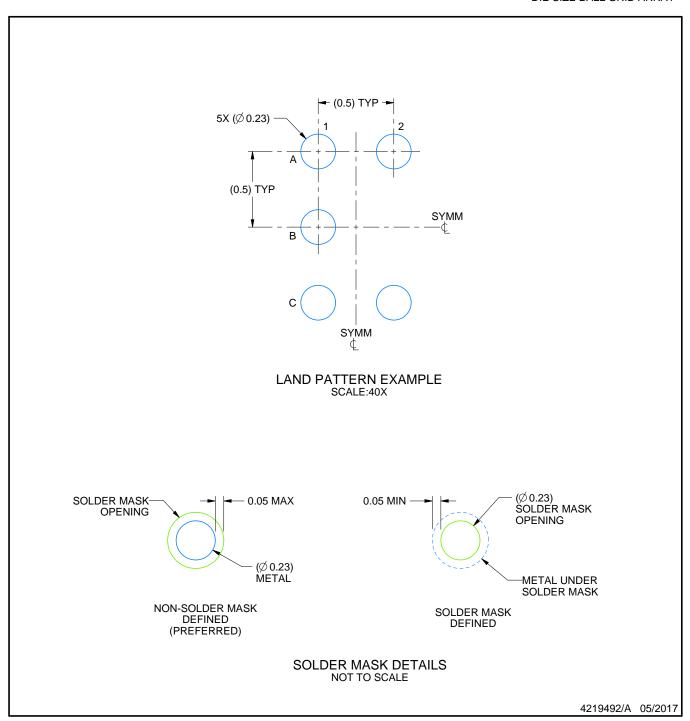


#### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY

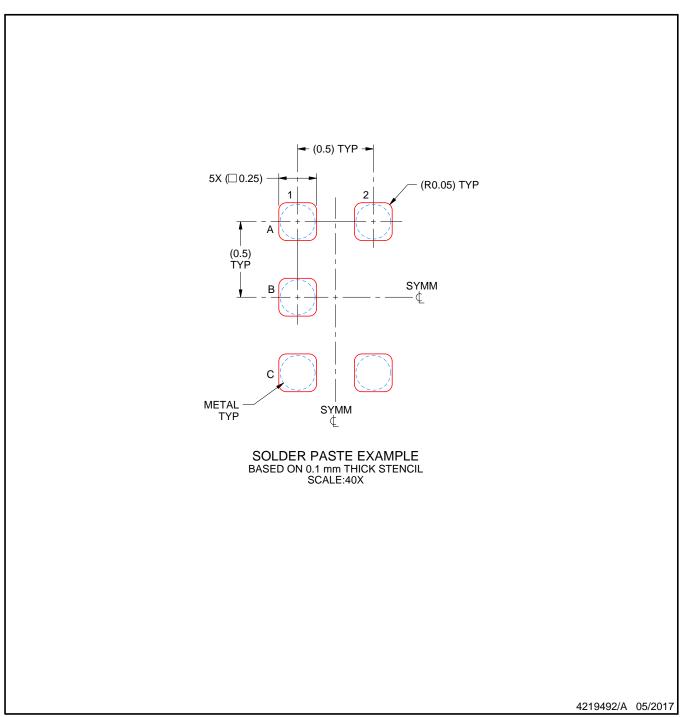


NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY

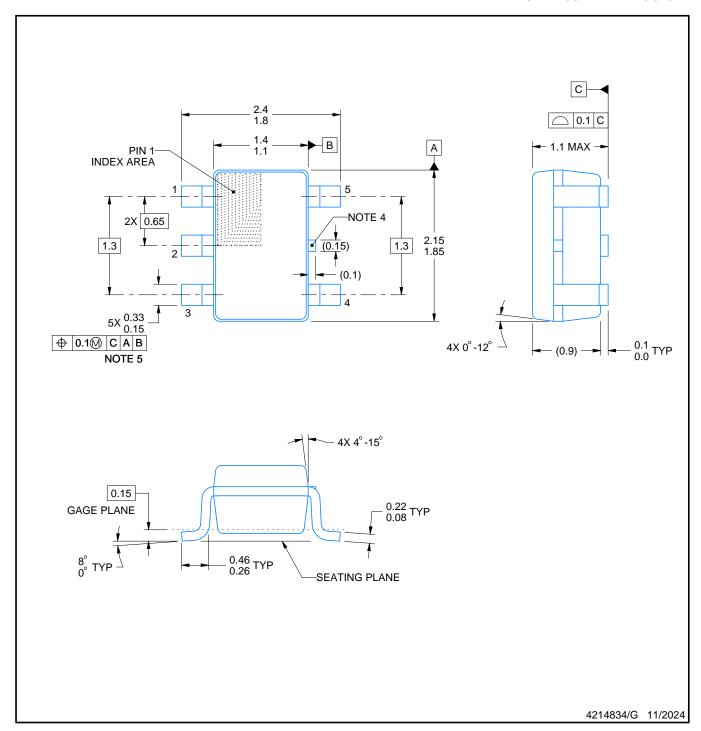


NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.





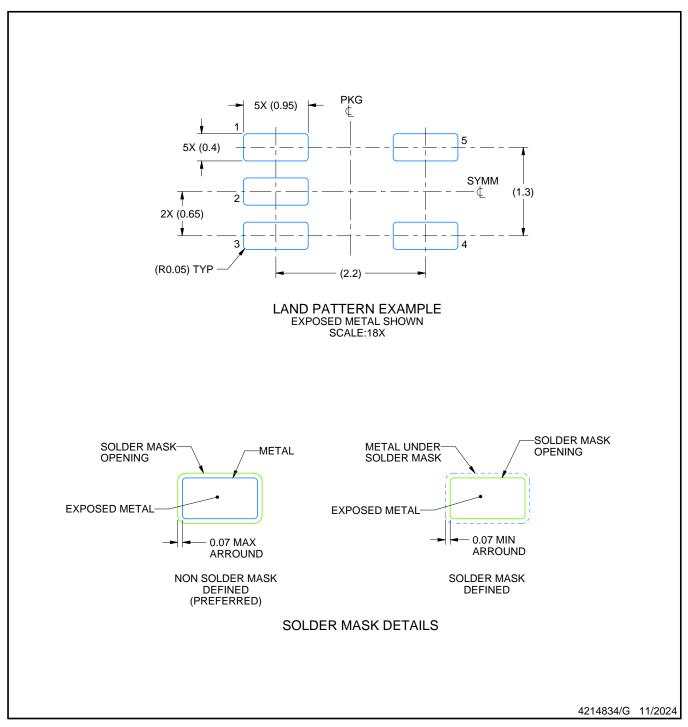


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-203.

- 4. Support pin may differ or may not be present.5. Lead width does not comply with JEDEC.
- 6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side

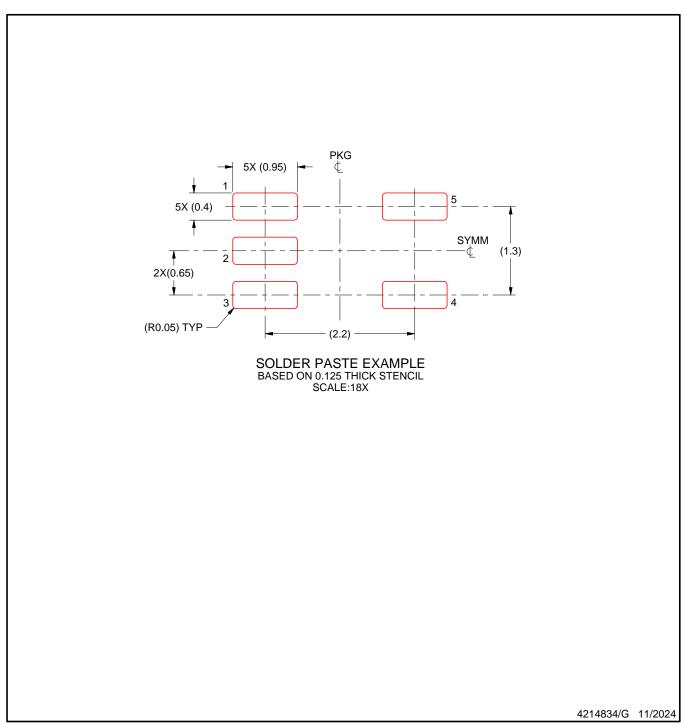




NOTES: (continued)

7. Publication IPC-7351 may have alternate designs.8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



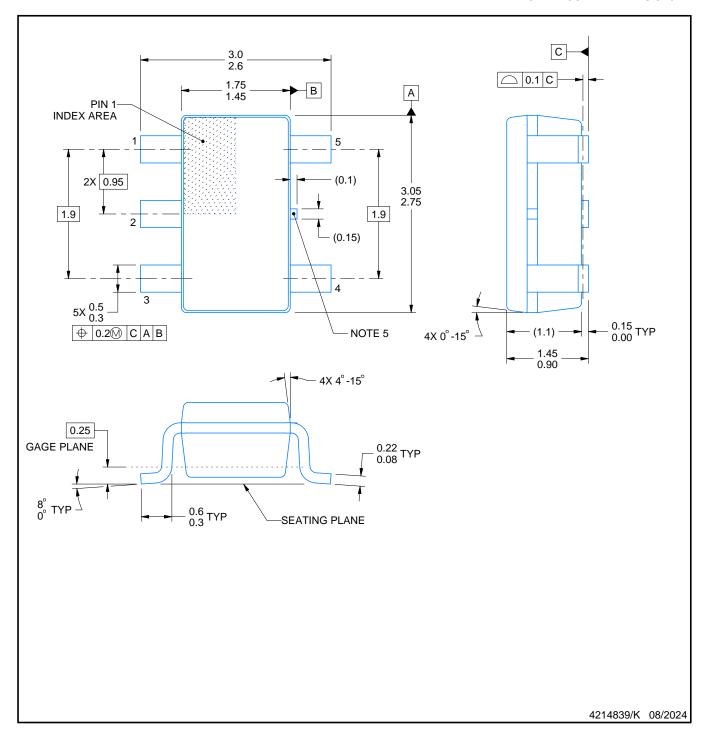


NOTES: (continued)

- 9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 10. Board assembly site may have different recommendations for stencil design.





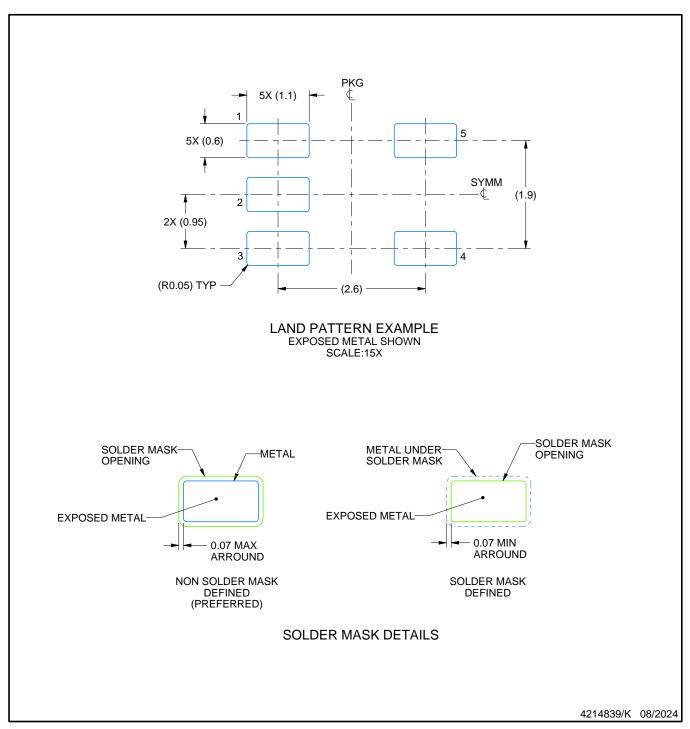


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



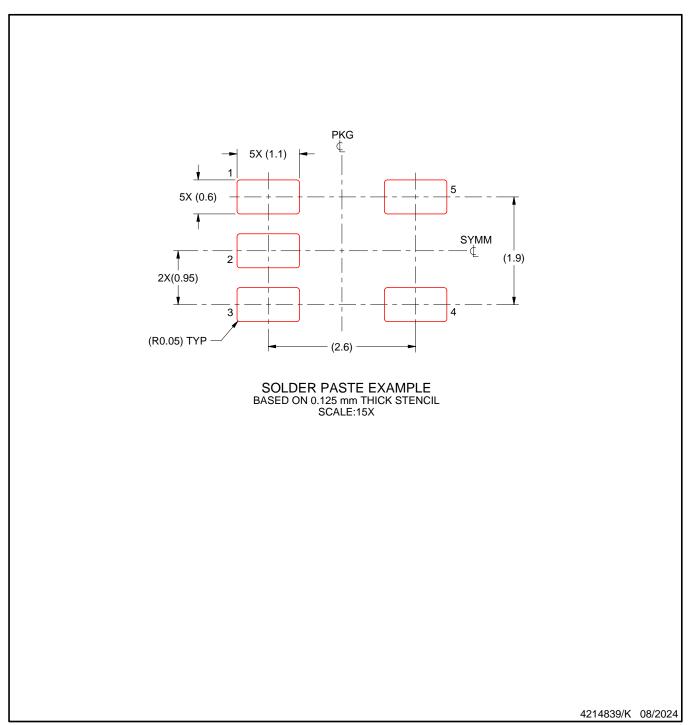


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



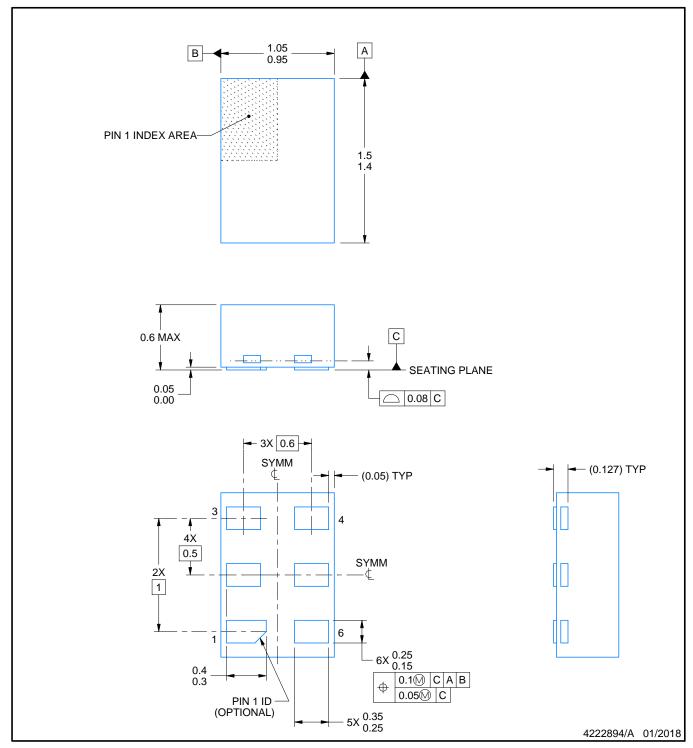


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.







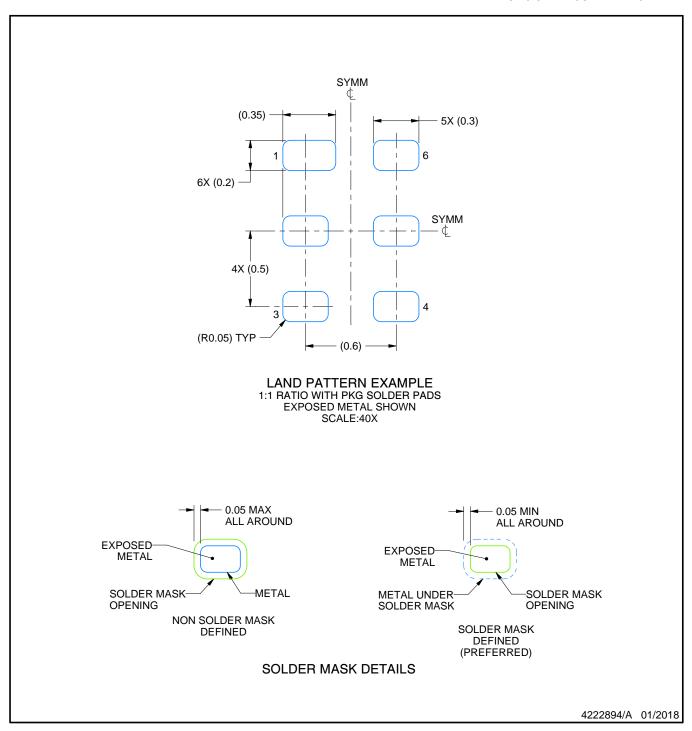


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

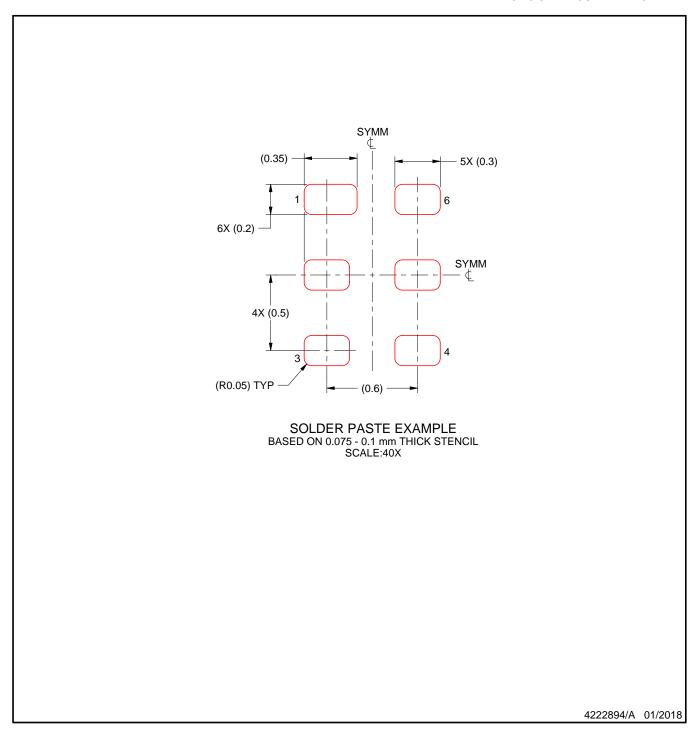




NOTES: (continued)

3. For more information, see QFN/SON PCB application report in literature No. SLUA271 (www.ti.com/lit/slua271).



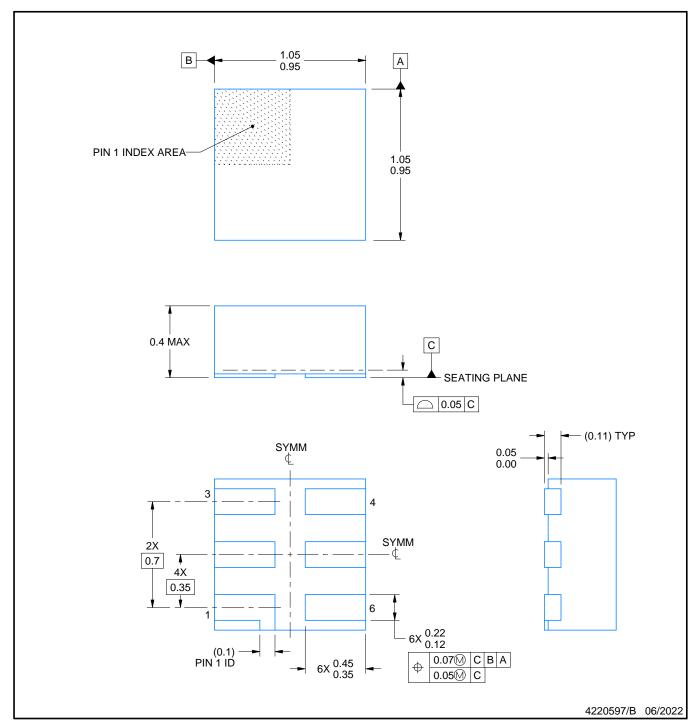


NOTES: (continued)

Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.







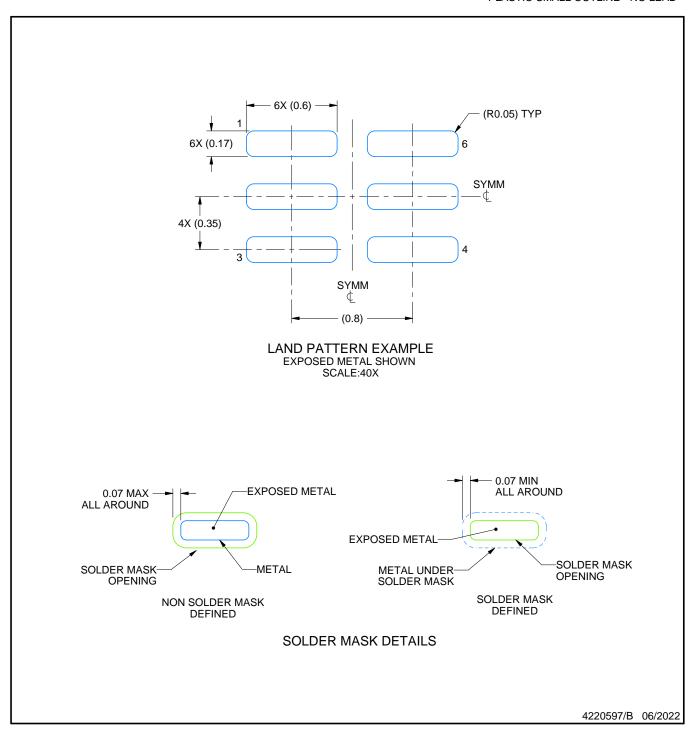
#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. Reference JEDEC registration MO-287, variation X2AAF.

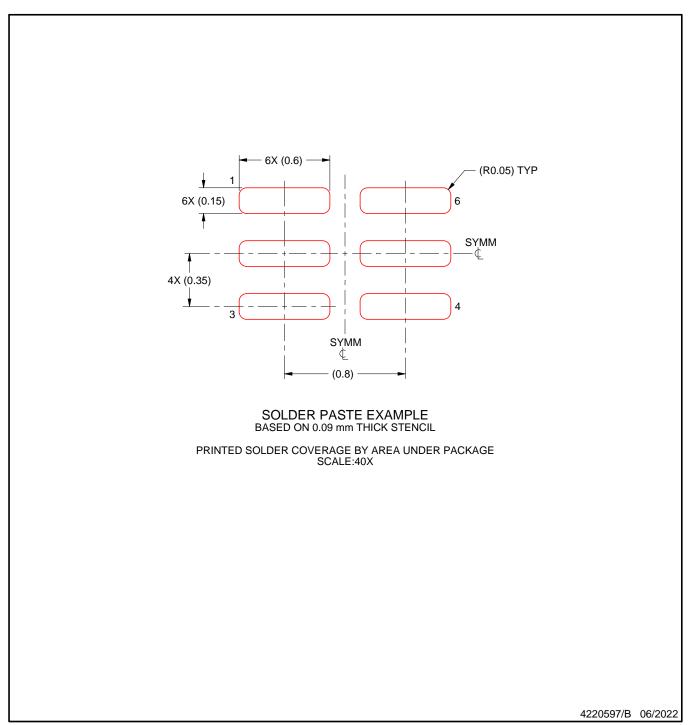




NOTES: (continued)

4. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).





4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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